MOSFET – Power, Dual N-Channel, Logic Level 60 V, 65 mΩ, 12 A

Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- 175°C Operating Temperature
- NVMFD5489NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb–Free Device

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

| | (.] =0 | | | | - |
|---|---------------------------------------|-------------------------|-----------------------------------|---------------|------|
| Parameter | | | Symbol | Value | Unit |
| Drain-to-Source Voltage | | | V _{DSS} | 60 | V |
| Gate-to-Source Voltage | | | V _{GS} | ±20 | V |
| Continuous Drain Current $R_{\Psi J-mb}$ | | T _{mb} = 25°C | Ι _D | 12 | A |
| (Notes 1, 2, 3, 4) | Steady | $T_{mb} = 100^{\circ}C$ | | 8.8 | |
| Power Dissipation $R_{\Psi J-mb}$ (Notes 1, 2, 3) | State | $T_{mb} = 25^{\circ}C$ | PD | 23.4 | W |
| | | $T_{mb} = 100^{\circ}C$ | | 11.7 | |
| Continuous Drain Current $R_{\theta JA}$ | | T _A = 25°C | Ι _D | 4.5 | А |
| (Notes 1, 3 & 4) | Steady | T _A = 100°C | | 3.2 | |
| Power Dissipation | State | T _A = 25°C | PD | 3.0 | W |
| R _{0JA} (Notes 1 & 3) | | T _A = 100°C | | 1.5 | |
| Pulsed Drain Current | $T_A = 25^{\circ}C, t_p = 10 \ \mu s$ | | I _{DM} | 62 | А |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | -55 to 175 | °C |
| Source Current (Body Diode) | | | ۱ _S | 22 | А |
| Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, I _{L(pk)} = 19.5 A, L = 0.1 mH, R _G = 25 Ω) | | E _{AS} | 19 | mJ | |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | ΤL | 260 | °C | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Mounting Board (top) - Steady State (Notes 2, 3) | $R_{\Psi J-mb}$ | 6.4 | |
| Junction-to-Ambient - Steady State (Note 3) | | 50 | °C/W |
| Junction-to-Ambient - Steady State (min footprint) | R_{\thetaJA} | 161 | |

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

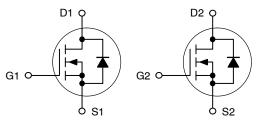


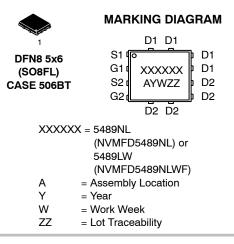
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| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 60 V | 65 mΩ @ 10 V | 12 A |
| 00 V | 79 mΩ @ 4.5 V | 127 |

Dual N-Channel





ORDERING INFORMATION

| Device | Package | Shipping [†] |
|------------------|-------------------|-----------------------|
| NVMFD5489NLT1G | DFN8 (Pb-Free) | 1500/ Tape & Reel |
| NVMFD5489NLT3G | DFN8 (Pb-Free) | 5000/ Tape & Reel |
| NVMFD5489NLWFT1G | DFN8 (Pb-Free) | 1500/ Tape & Reel |
| NVMFD5489NLWFT3G | DFN8 (Pb-Free) | 5000/ Tape & Reel |

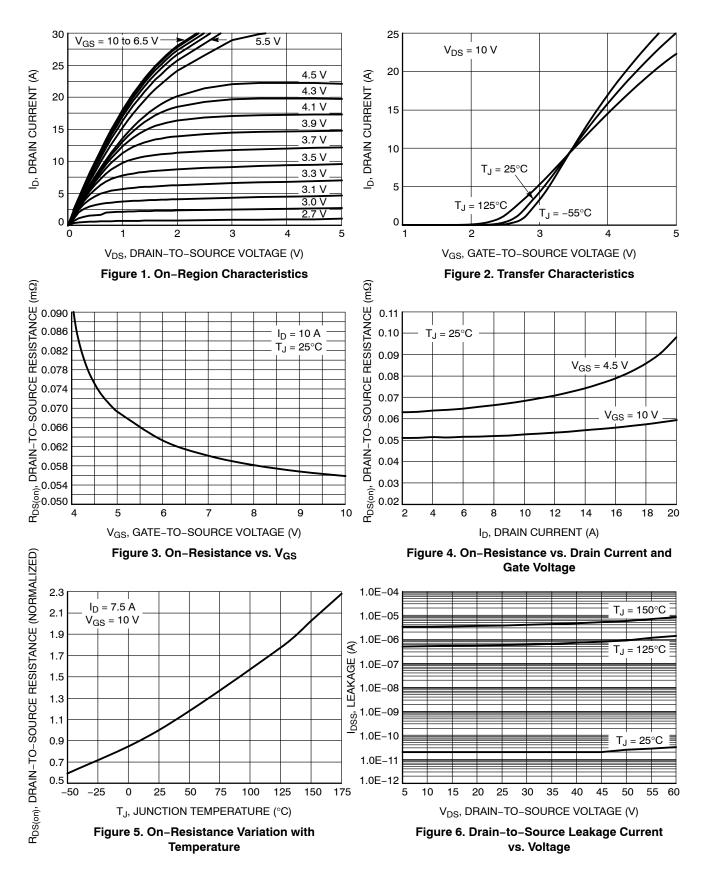
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

- Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
 Continuous DC current rating. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

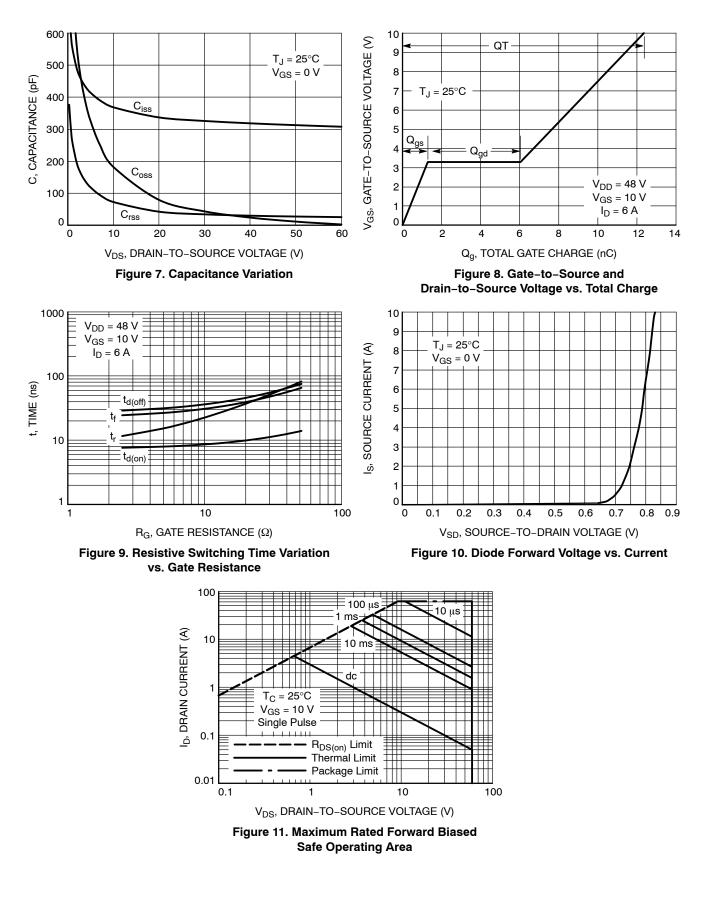
| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--------------------------------------|--|---|-----|-------|-----------|-------|
| OFF CHARACTERISTICS | | | | | • | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0 V, I _D = 250 μA | | 60 | 1 | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | Reference to $25^{\circ}C$ $I_D = 250 \mu A$ | | | 67 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, V _{DS} = 60 V | T _J = 25°C T _J = 125°C | | | 1.0 10 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = ±20 V | | | | ±100 | nA |
| ON CHARACTERISTICS (Note 5) | 0.00 | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | V _{GS} = V _{DS} , I _D = | 250 μA | 1.5 | | 2.5 | V |
| Negative Threshold Temperature Co- efficient | V _{GS(TH)} /T _J | Reference to 25° C I _D = 250 μ A | | | 4.86 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 15 A | | | 52 | 65 | mΩ |
| | ~ / | V _{GS} = 4.5 V, I _D = | = 7.5 A | | 66 | 79 | - |
| CHARGES AND CAPACITANCES | | | | | • | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V | | | 330 | | pF |
| Output Capacitance | C _{oss} | | | | 80 | | |
| Reverse Transfer Capacitance | C _{rss} | | | | 39 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 48 V, I _D = 6 A | | | 12.4 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 0.31 | | |
| Gate-to-Source Charge | Q _{GS} | | | | 1.3 | | |
| Gate-to-Drain Charge | Q _{GD} | | | | 4.74 | | |
| SWITCHING CHARACTERISTICS (No | ote 6) | | | | | | |
| Turn–On Delay Time | t _{d(on)} | | | | 7 | | ns |
| Rise Time | tr | V_{GS} = 10 V, V_{DS} = 48 V, I _D = 6 A, R _G = 2.5 Ω | | | 11 | | |
| Turn-Off Delay Time | t _{d(off)} | | | | 31 | | 1 |
| Fall Time | t _f | | | | 21 | | |
| DRAIN-SOURCE DIODE CHARACTE | RISTICS | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | | 0.83 | 1.2 | V |
| | | $I_{\rm S} = 10 {\rm A}$ | T _J = 125°C | | 0.71 | | 1 |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 V, d_{IS}/d_t = 100 A/\mu s,$ $I_S = 10 A$ | | | 24.2 | | ns |
| Charge Time | t _a | | | | 20.2 | | |
| Discharge Time | t _b | | | | 4.0 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 26.5 | | nC |
| PACKAGE PARASITIC VALUES | | | | | | | |
| Source Inductance | L _S | T _A = 25°C | | | 0.93 | | nH |
| Drain Inductance | L _D | | | | 0.005 | | 1 |
| Gate Inductance | L _G | | | | 1.84 | | 1 |
| Gate Resistance | R _G | | | | 12 | | Ω |

5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



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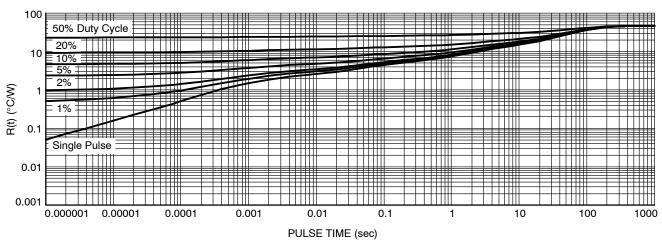
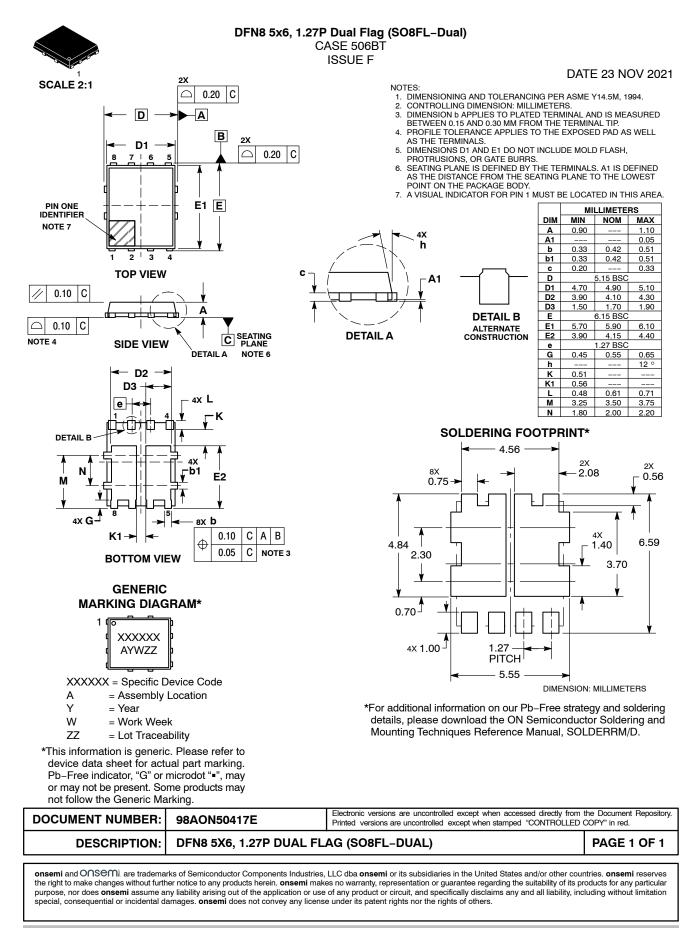


Figure 12. Thermal Response

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

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